MOSFET – Power, Dual, N-Channel with Integrated Schottky, SO8FL

30 V, High Side 18 A / Low Side 23 A

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Low Side MOSFET with Integrated Schottky
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

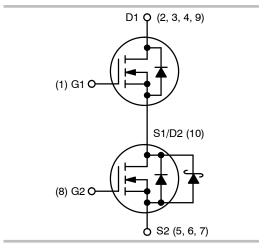
- DC-DC Converters
- System Voltage Rails
- Point of Load



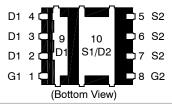
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
Q1 Top FET	6.5 mΩ @ 10 V	10 /
30 V	10 mΩ @ 4.5 V	18 A
Q2 Bottom	4.1 mΩ @ 10 V	23 A
FET 30 V	6.2 mΩ @ 4.5 V	23 A



PIN CONNECTIONS



MARKING DIAGRAM



DFN8 CASE 506BX



4902NF = Specific Device Code A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit		
Drain-to-Source Voltage	Q1	V _{DSS}	30	V		
Drain-to-Source Voltage	Q2					
Gate-to-Source Voltage	Q1	V _{GS}	±20	V		
Gate-to-Source Voltage			Q2			
Continuous Drain Current R _{θJA} (Note 1)		T _A = 25°C	Q1	I _D	13.5	
		T _A = 85°C			9.7	1 .
		T _A = 25°C	Q2		17.5	A
		T _A = 85°C			12.6	
Power Dissipation		T _A = 25°C	Q1	P _D	1.90	W
RθJA (Note 1)			Q2		1.99	
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$		T _A = 25°C	Q1	I _D	18.2	
		T _A = 85°C			13.1	1
	Steady	T _A = 25°C	Q2		23	A
	State	T _A = 85°C	1		16.6	1
Power Dissipation		T _A = 25°C	Q1	P _D	3.45	W
$R_{\theta JA} \le 10 \text{ s (Note 1)}$			Q2		3.45	
Continuous Drain Current		T _A = 25°C	Q1	I _D	10.3	
R _{θJA} (Note 2)		T _A = 85°C	1		7.4	1 .
		T _A = 25°C	Q2		13.3	A
		T _A = 85°C	1		9.6	
Power Dissipation		T _A = 25 °C	Q1	P_{D}	1.10	W
R _{θJA} (Note 2)			Q2		1.16	
Pulsed Drain Current		TA = 25°C	Q1	I _{DM}	60	Α
		tp = 10 μs	Q2		80	
Operating Junction and Storage Temperature				T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)				I _S	3.4	Α
	Q2		4.9	1		
Drain to Source dV/dt		dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (T		24 A	Q1	EAS	28.8	mJ
$V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_L = XX A_{pk}, L = 0.1 \text{ mH}, R_0$	$_{\rm G}$ = 25 Ω)	27 A	Q2	EAS	36.5	1
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)						°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	FET	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	Q1	$R_{\theta JA}$	65.9	
	Q2		62.8	
Junction-to-Ambient - Steady State (Note 4)	Q1	$R_{\theta JA}$	113.2	0000
	Q2		108	°C/W
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	Q1	$R_{\theta JA}$	36.2	1
	Q2		36.2	

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

FLECTRICAL CHARACTERISTICS (T.

Parameter	FET	Symbol	Test C	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS								
Drain-to-Source Break-	Q1	V _{(BR)DSS}	V _{GS} = 0 V,	I _D = 250 μA	30			V
down Voltage	Q2		V _{GS} = 0 V,	I _D = 1.0 mA	30			
Drain-to-Source Break-	Q1	V _{(BR)DSS}				18		mV /
down Voltage Temperature Coefficient	Q2	`/Ť _J				15		°C
Zero Gate Voltage Drain	Q1	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1	μΑ
Current			$V_{DS} = 24 \text{ V}$	T _J = 125°C			10	
	Q2		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			500	
Gate-to-Source Leakage	Q1	I _{GSS}	V _{GS} = 0 V,	VDS = ±20 V			±100	nA
Current	Q2						±100	
ON CHARACTERISTICS (Not	e 5)				•			
Gate Threshold Voltage	Q1	V _{GS(TH)}	V _{GS} = VDS	, I _D = 250 μA	1.2		2.2	V
	Q2]			1.2		2.2	
Negative Threshold Temperature Coefficient	Q1	V _{GS(TH)} /				4.5		mV / °C
ature Coefficient	Q2	T _J				4.0		
Drain-to-Source On Resist-	Q1	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		5.2	6.5	
ance			V_{GS} = 4.5 V	I _D = 10 A		8.0	10	mΩ
	Q2		V _{GS} = 10 V	I _D = 15 A		3.3	4.1	11175
			V _{GS} = 4.5 V	I _D = 15 A		5.0	6.2	
Forward Transconductance	Q1	9FS	$V_{DS} = 1.5 \text{ V}, I_D = 10 \text{ A}$			28		S
	Q2					35		
CHARGES, CAPACITANCES	& GATE	RESISTANCE	E					
Q1 Q						1150		
Input Capacitance	Q2 C _{ISS}				1590			
Output Canacitanas	Q1		V 0V4 4	4.101.17		360		
Output Capacitance	Q2	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, V}_{DS} = 15 \text{ V}$			813		pF	
Deverse Constitutes	Q1					105		
Reverse Capacitance	Q2	C _{RSS}				83		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

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- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

CHARGES, CAPACITANCES & GATE RESISTANCE Total Gate Charge Ω1 / Ω2	Parameter	FET	Symbol	Test Co	ondition	Min	Тур	Max	Unit
Total Gate Charge Q2	CHARGES, CAPACITANCES	& GATE	RESISTANC	E		-	<u>-</u>	-	-
Threshold Gate Charge Q1 Q2 Q3 Q3 Q4 Q5 Q5 Q5 Q5 Q5 Q5 Q5	T. 10 . 0	Q1				9.7			
Threshold Gate Charge Q2 Q3 Q3 Q4 Q4 Q4 Q5 Q5 Q5 Q5 Q5	Total Gate Charge	Q2	$Q_{G(TOT)}$				11.5		
Cate	The state of the Color Observed	Q1	0				1.1		
Gate - to - Source Charge Q1 QG QG QG QG 3.3 A 4.2 A.2 A.2 A.2 A.2 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.7 A.3.4 A.2 A.3.7 A.3.7 A.3.4 A.2 A.3.7	Inresnoid Gate Charge	Q2	- Q _{G(TH)}	\/ 45\/\/	45.761 40.4		1.4		0
Gate-to-Drain Charge Q1 Q2 Q3 Q4	Oata ta Caura Chara	Q1	0	$V_{GS} = 4.5 \text{ V}, V_{DS}$	= 15 V; I _D = 10 A		3.3		nC
Gate-to-Drain Charge Q2	Gate-to-Source Charge	Q2	— Q _{GS}				4.2		
Total Gate Charge Q1	Cata ta Duain Chausa	Q1	0			3.7			
Total Gate Charge Q2	Gate-to-Drain Charge	Q2	u _{GD}				3.4		
SWITCHING CHARACTERISTICS (Note 6) 24.9	Tatal Cata Chausa	Q1	0	V 40VV	45 \		19.1		0
Turn-On Delay Time Q1	Total Gate Charge	Q2	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS}$	= 15 V; I _D = 10 A		24.9		nC
Turn-On Delay Time	SWITCHING CHARACTERIS	STICS (No	te 6)						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn On Dolov Time		+				9.0		
Rise Time Q2	Q2 Q1	Q2	t _{d(ON)}				10.5		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		Q1					15		ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	Q2	t _r	V _{GS} = 4.5 V,	V _{DS} = 15 V,		15.2		
Fall Time Q2		Q1		$I_D = 10 \text{ A},$	$R_G = 3.0 \Omega$		14		
Fall Time Q2 t _f 4.7 4.7	Turn-Off Delay Time	Q2	^t d(OFF)				17.7		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	E U.T.	Q1					4.0		
	Fall Time	Q2	t _f				4.7		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING CHARACTERIS	STICS (No	te 6)						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn On Dalau Tina	Q1					6.0		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	Q2	^t d(ON)				7.0		
	Dia Tina	Q1					14		
	Hise Time	Q2	T _r	V _{GS} = 10 V,	V _{DS} = 15 V,		14		
	Turn-Off Delay Time	Q1		$I_D = 10 \text{ A}, R_G = 3.0 \Omega$			17		ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		Q2	^t d(OFF)				22		1
	E 11.7	Q1					3.0		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	Q2	t _f				3.3		
Forward Voltage V_{SD} V_{SD} $V_{GS} = 0 \text{ V},$ $V_{GS} = 0 \text{ V},$ $V_{J} = 125 \text{ °C}$ $V_{J} = 25 \text{ °C}$ $V_{J} = 2$	DRAIN-SOURCE DIODE CH	IARACTE	RISTICS			-	-	-	
Forward Voltage V_{SD} V_{SD} V_{SD} $V_{GS} = 0 \text{ V},$ $V_{J} = 125 ^{\circ}\text{C}$ 0.62 $V_{J} = 25 ^{\circ}\text{C}$ 0.37 0.70		6.		V _{GS} = 0 V.	T _J = 25°C		0.75	1.0	
$V_{GS} = 0 \text{ V}, \qquad I_J = 25 \text{ C} \qquad 0.37 \qquad 0.70$		Q1		I _S = 3 A	T _J = 125°C		0.62		
	Forward Voltage		V_{SD}	V _{GS} = 0 V ₂	T _J = 25°C		0.37	0.70	V
		Q2		I _S = 2 A	T _J = 125°C		0.31	1	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CH	ARACTE	RISTICS					
	Q1				23		
Reverse Recovery Time	Q2	t _{RR}			24.5		1
Charra Time	Q1	1-			12		l
Charge Time	Q2	ta	V 0V d /d 400 A / 5 L 0 A		13		ns
Disabassa Tisa	Q1	11-	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 3 \text{ A}$		11		1
Discharge Time	ischarge Time tb			11.5		1	
Daviera Daviera Charre	Q1	0			12		nC
Reverse Recovery Charge	Q2	Q_{RR}			24		
PACKAGE PARASITIC VALU	IES						
Cauraa Industanaa	Q1	1			0.38		الم
Source Inductance	Q2	L _S			0.65		nH
Duain Industria	Q1		T. 0500		0.054		-11
Drain Inductance Q2	Q2	L _D			0.007		nH
Gate Inductance Q1 Q2		$T_A = 25^{\circ}C$		1.5			
	Q2	L _G			1.5		nH
Cata Basistanas	Q1	Б			0.8		
Gate Resistance	Q2	R_{G}			0.8		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

- 6. Switching characteristics are independent of operating junction temperatures.

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFD4902NFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4902NFT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS - Q1

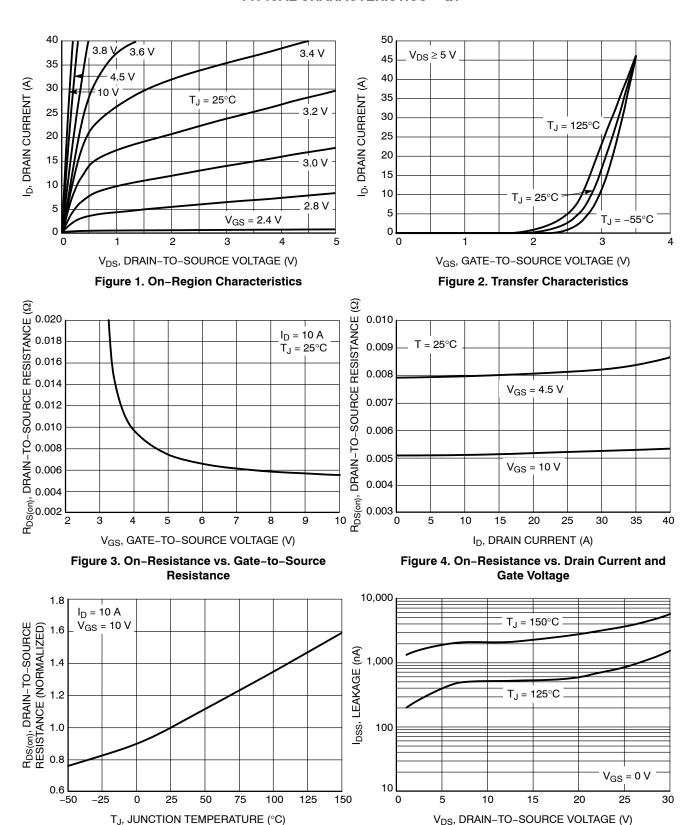


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS - Q1

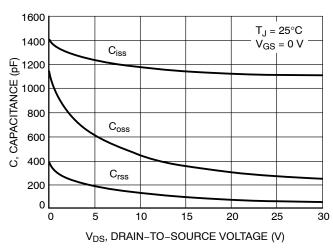


Figure 7. Capacitance Variation

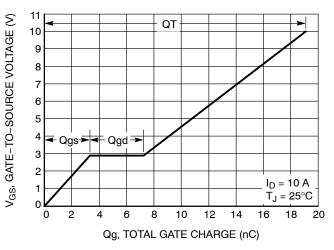


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

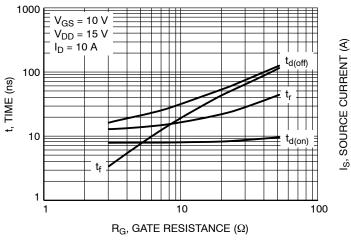


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

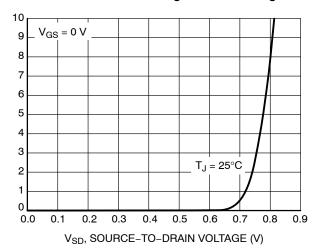
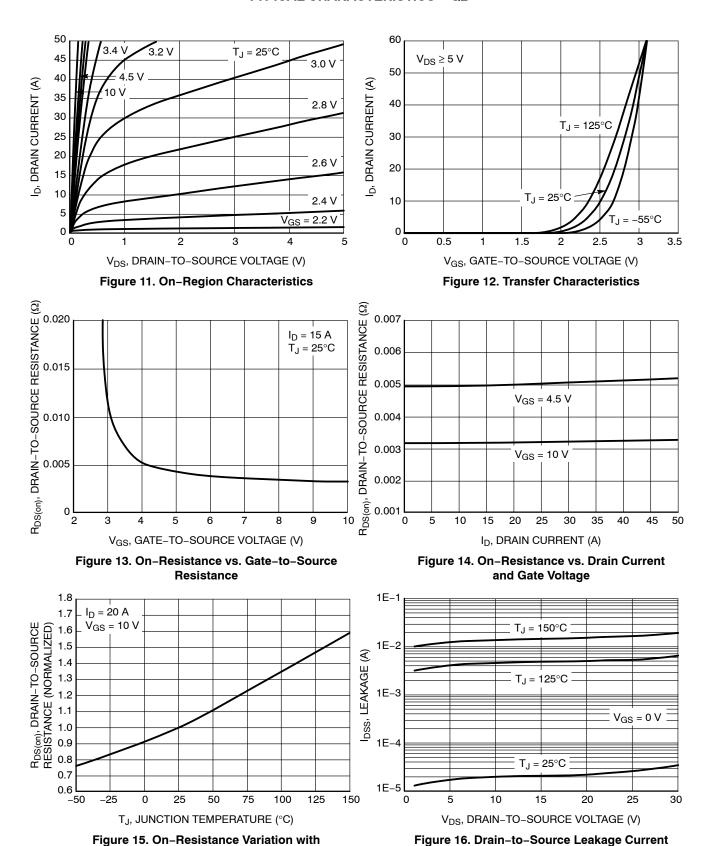


Figure 10. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS - Q2



vs. Voltage

Temperature

TYPICAL CHARACTERISTICS - Q2

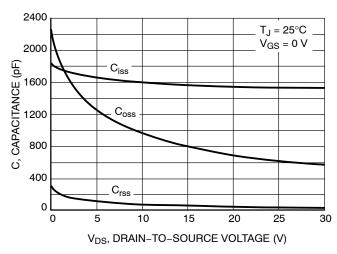


Figure 17. Capacitance Variation

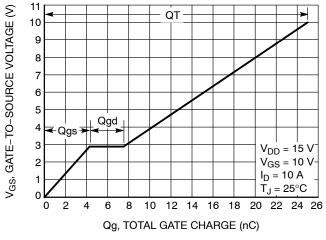


Figure 18. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

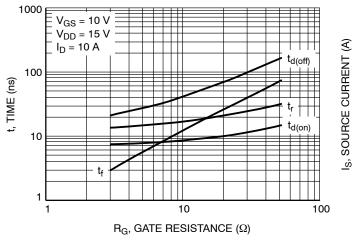


Figure 19. Resistive Switching Time Variation vs. Gate Resistance

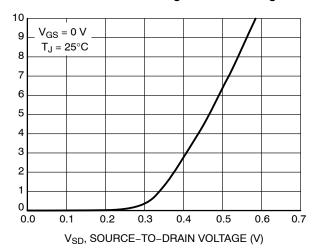
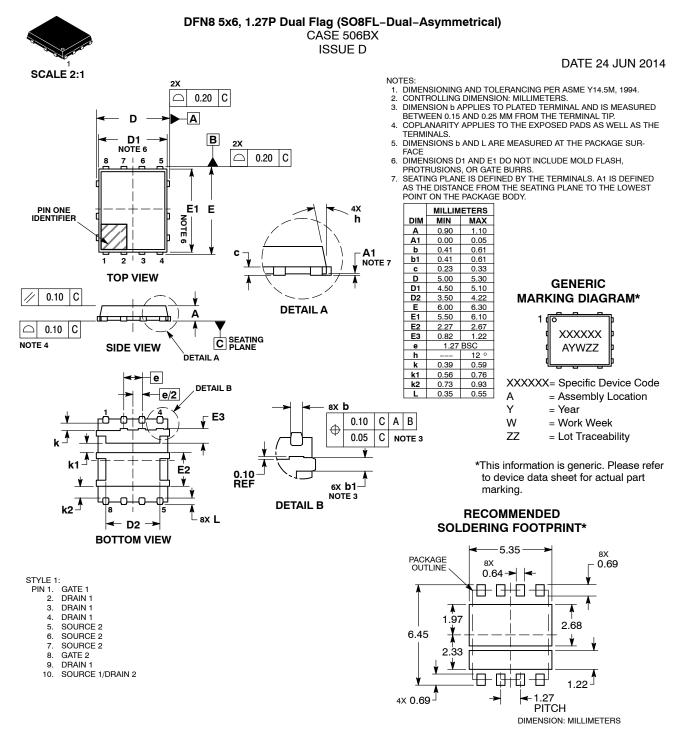


Figure 20. Diode Forward Voltage vs. Current



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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